

ET-100 HANDHELD THERMAL EMISSOMETER

Total hemispherical emittance measurements

The ET-100 measures directional reflectance from 1.5 to 21 μm and, based on those values, calculates directional and total hemispherical emissivity. The ET100 Emissometer conforms to ASTM E408, the standard test method for the determination of emittance using a portable instrument. In-band reflectance data for six discrete bands.



BENEFITS

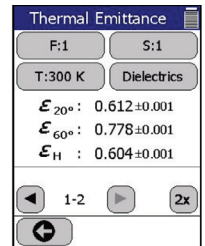
- **ASTM compliant**
Use for ASTM E408 and E1980.
- **6 discrete bands**
1.5-2.0, 2.0-3.5, 3.0-4.0, 4.0-5.0, 5.0-10.5, 10.5-21.
- **Immediate warm up**
90 sec warm up, no equilibration between measurements.
- **Room temperature samples**
Calculate emissivity without heating sample.
- **Two incident angles**
Data for 20° and 60° angles of incidence.
- **Emittance for multiple materials**
Metals & dielectrics.
- **Elevated temperature model**
Calculate emittance at any temperature Kelvin.
- **In-Band spectral resolution**
Increased accuracy over broadband for selective radiating materials.
- **Gier Dunkle DB-100**
Replacement for discontinued DB-100.

APPLICATIONS

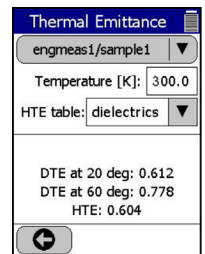
- **Space Coatings**
Thermal control | α/ϵ | Thermo-optical properties
- **Defense | Aerospace**
IR Signature | Low observable paint & coatings
- **Radiative Heat Transfer**
Absorptance for thermal modeling
- **Semiconductors**
Wafer fab hardware emissivity
- **Cool Building Materials**
SRI | ASTM | LEED
- **Energy**
Nuclear | Concentrated Solar

EXAMPLE MENU SCREENS

Directional and hemispherical emittance measurement data screen.



Set temperature and material type for Hemispherical Thermal Emittance calculation.



ORDERING

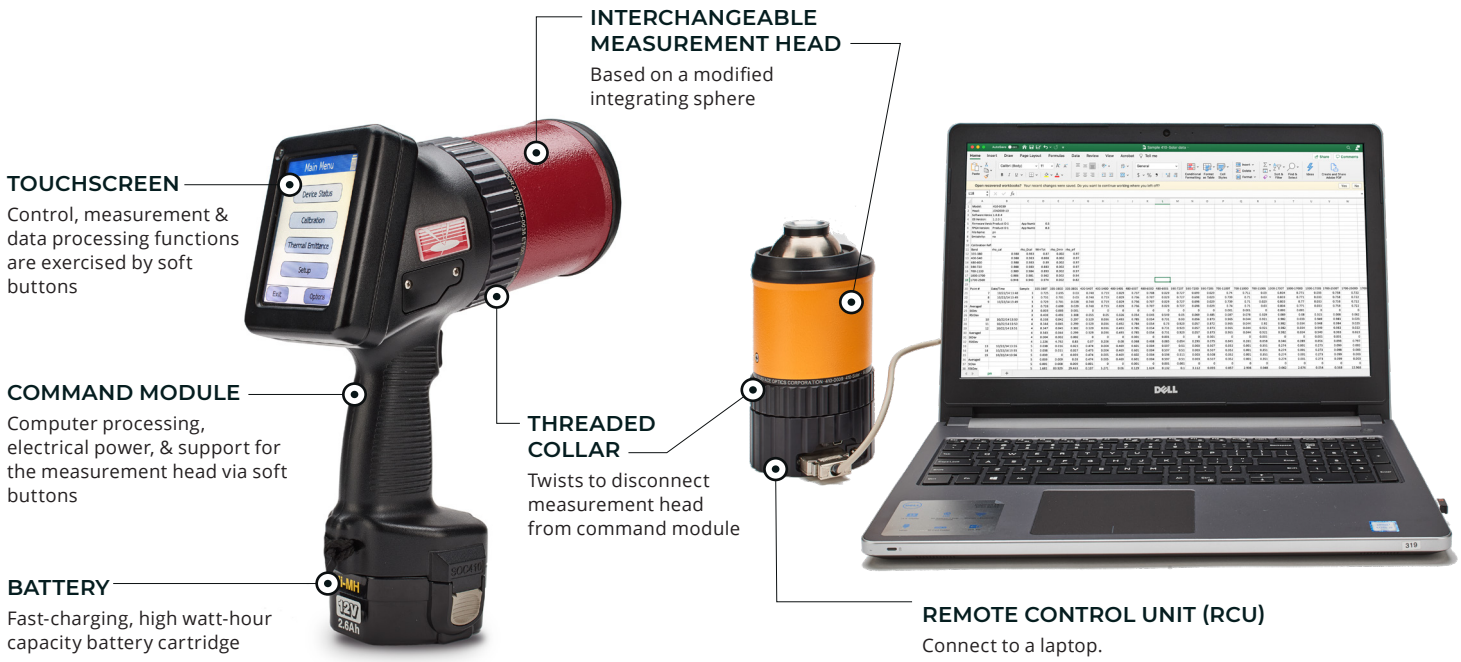
Standard components	0410-0007	ET100 Emissometer Measurement Head
	0410-0001	Handheld Command Module - 120VAC
	0410-0100	Specular Gold Calibration Coupon (Non-NIST Traceable)
Options	0410-0002	Benchtop Remote Control Unit - 120VAC
	0410-0101	Specular Gold Calibration Coupon (NIST Traceable)
	0410-1016	410-Series Reflectometer Maintenance and Calibration Plan (Non-NIST)
	0410-1009	410-Series Reflectometer Maintenance and Calibration Plan (NIST)
	0410-1003	ET100 Extended Warranty
	0410-0204	SD Card for Extra Data Storage
	0410-0200	Handheld Command Module - 220VAC
	0410-0019	Benchtop Remote Control Unit - 220VAC

CE Equipment described herein is subject to US export regulations and may require a license prior to export. Diversion contrary to US law is prohibited.

SPECIFICATIONS ET-100

ET-100	
MEASURED DATA	
<i>Measured Parameter</i>	Directional hemispherical reflectance (DHR)
<i>Method</i>	Integrated total reflectance in a band for a given angle of incidence
<i>Measured Value</i>	Absolute reflectance (0-1)
<i>Calculated Value</i>	Directional thermal emissivity at 20°, directional thermal emissivity at 60°, hemispherical thermal emissivity
<i>Wavelength Bands (microns)</i>	1.5-2.0, 2.0-3.5, 3.0-4.0, 4.0-5.0, 5.0-10.5, 10.5-21
<i>Angle of Incidence</i>	20° & 60° from normal incidence
<i>ASTM Standards</i>	E903
<i>Calibration Coupon</i>	Specular Gold
PERFORMANCE	
<i>Accuracy</i>	+/- .03
<i>Repeatability</i>	±.005 units
<i>Beam Spot Size</i>	0.50 inches
<i>Measurement Time</i>	10 sec
<i>Sample Size & Geometry</i>	Flat: ≥ 0.5 in. diameter Curved: 6 in. convex; 12 in. concave
<i>Warm Up Time</i>	90 seconds
<i>Time Between Measurements</i>	2 seconds
<i>Sample Temperature</i>	Ambient or heated/cooled to 0 - 100° C
<i>Operating Temp</i>	0° to 40° C
POWER	
<i>Run Time</i>	2 hours on one battery. Battery easily replaced with continuous operation after battery replacement.
<i>Power Source</i>	Rechargeable battery (standard environmentally friendly NiMH)
<i>Battery Recharge Time</i>	1 hour
<i>IR Source</i>	Kanthal filament operated at about 1,000°C
ENVIRONMENT	
<i>Storage</i>	-25° to 70°C
<i>Operating</i>	0° to 40° C
DIMENSIONS	
<i>Weight</i>	4.7 lbs
<i>Form Factor/Size</i>	H 11.54", L 9.04", W 3.27" (29.31 cm x 22.96 cm x 9.44 cm)
INTERFACE	
<i>Operator Interface</i>	LCD graphics screen, 1/4 VGA, touch screen, software buttons; trigger switch in handle
<i>Inspection Applications</i>	Pass/fail can be incorporated, user set values
<i>Diagnostics</i>	On screen status and signals monitor. Signal values stored with data. Raw data collection and display.
MISCELLANEOUS	
<i>Date Format</i>	Data files can be opened and post processed with Excel or a text processor
<i>Data Storage</i>	Removable SanDisk (SD) card
<i>Export control</i>	ECCN #3A999.F

410 SERIES REFLECTOMETERS & EMISSOMETERS



HANDHELD CONFIGURATION

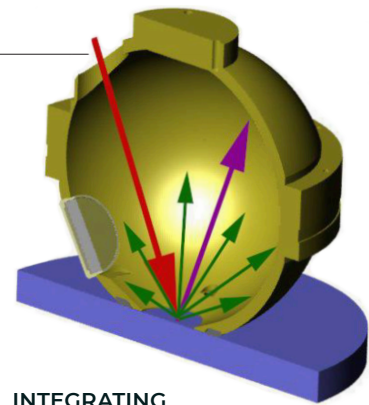
BENCHTOP CONFIGURATION

METHODOLOGY

The basic structure of a measurement head is an internal source, a modified integrating sphere, and detectors. The reflectance measurement is made by collimating the source beam onto the target, the energy is reflected back into the sphere, and eventually detected or dissipated.

The 410 Series Reflectometers measures the integrated surface reflectance of a surface at a given angle of incidence (20° or 60°). The integrating sphere captures the reflected light from the target material, integrating reflections in all directions. Wavelength-filtered detectors measure the total light reflected in each wavelength band and converts it to an analog electrical signal.

The 410 Series Reflectometer electronics processes the detector signals for initial amplification (fixed), filtering, offset adjustment, secondary amplification (variable), and analog to digital conversion. The digitized signals are read by the on-board processor, stored in memory, and then used to determine the target sample reflectance at each incident angle and wavelength band. Those reflectances are used to calculate additional properties such as directional thermal emittance or total hemispherical emittance. Results are displayed on the liquid crystal display touchscreen, and stored on a SecureDigital (SD) card.



INTEGRATING SPHERE SCHEMATIC

Schematic of the integrating sphere in contact with a sample.
Red arrow - illuminating beam
Purple arrow - reflected beam
Green arrows - scattered light

CALIBRATION COUPON



CALIBRATION

An easy calibration process is required before each measurement session. The software GUI will walk the user through the process. Calibration is performed using calibration coupon(s) with known reflectance values.

410 REFLECTOMETERS MODEL COMPARISON GUIDE

The SOC410 Series Reflectometers are portable contact measurement devices designed to take precise, accurate reflectance and emittance measurements. Made with an ergonomic power-drill design, the SOC410 Series lets you easily take measurements in-the-field or around the lab—no cords or external batteries necessary. The world's largest defense, aerospace, and energy companies rely on SOC410 data.



Model	410-Solar	410-Solar-i	410-VIS-IR	ET-100	ET-10	410-DHR
<i>Spectral Bands</i>	335 - 380 nm 400 - 540 nm 480 - 600 nm 590 - 720 nm 700 - 1100 nm 1000 - 1700 nm 1700 - 2500 nm	335 - 380 nm 400 - 540 nm 480 - 600 nm 590 - 720 nm 700 - 1100 nm 1000 - 1700 nm 1700 - 2500 nm	Dual measurement head package consisting of a 410-Solar model and ET100 measurement heads with a single command module	1.5 - 2.0 μm 2.0 - 3.5 μm 3.0 - 4.0 μm 4.0 - 5.0 μm 5.0 - 10.5 μm 10.5 - 21.0 μm	3.0-5.0 μm 8.0-12.0 μm	0.9 - 1.1 μm 1.9 - 2.4 μm 3.0 - 4.0 μm 3.0 - 5.0 μm 4.0 - 5.0 μm 8.0 - 12.0 μm
<i>Calculated Properties</i>	Total, diffuse & specular reflectance absorptance	Total reflectance/absorptance		In-band total reflectance Directional thermal emissivity at 20° Directional thermal emissivity at 60° Hemispherical thermal emissivity	Directional thermal emissivity at 20°	In-band total reflectance In-band emissivity
<i>Angle of Incidence</i>	20°	20°		20° and 60°	20°	20° and 60°
<i>Calibration Coupon(s)</i>	Solar Diffuse Solar Specular	Glazed Ceramic		Specular Gold	Specular Gold	Specular Gold
<i>ASTM Compliance</i>	C1549 E903 E1980	C1549 E903 E1980		E408 E1980		N/A



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